

DUAL 4-CHANNEL ANALOG MULTIPLEXER/DEMULTIPLEXER

FEATURES

- Wide analog input voltage range:
± 5 V.
- Low "ON" resistance:
80 Ω (typ.) at $V_{CC} - V_{EE} = 4.5$ V
70 Ω (typ.) at $V_{CC} - V_{EE} = 6.0$ V
60 Ω (typ.) at $V_{CC} - V_{EE} = 9.0$ V
- Logic level translation:
to enable 5 V logic to communicate
with ± 5 V analog signals
- Typical "break before make" built in
- Output capability: non-standard
- I_{CC} category: MSI

GENERAL DESCRIPTION

The 74HC/HCT4052 are high-speed Si-gate CMOS devices and are pin compatible with the "4052" of the "4000B" series. They are specified in compliance with JEDEC standard no. 7A. The 74HC/HCT4052 are dual 4-channel analog multiplexers/demultiplexers with common select logic. Each multiplexer has four independent inputs/outputs (nY_0 to nY_3) and a common input/output (nZ). The common channel select logic include two digital select inputs (S_0 and S_1) and an active LOW enable input (E).

With E LOW, one of the four switches is selected (low impedance ON-state) by S_0 and S_1 . With E HIGH, all switches are in the high impedance OFF-state, independent of S_0 and S_1 .

V_{CC} and GND are the supply voltage pins for the digital control inputs (S_0 and S_1 , and E). The V_{CC} to GND ranges are 2.0 to 10.0 V for HC and 4.5 to 5.5 V for HCT. The analog inputs/outputs (nY_0 to nY_3 , and nZ) can swing between V_{CC} as a positive limit and V_{EE} as a negative limit. $V_{CC} - V_{EE}$ may not exceed 10.0 V.

For operation as a digital multiplexer/demultiplexer, V_{EE} is connected to GND (typically ground).

SYMBOL	PARAMETER	CONDITIONS	TYPICAL		UNIT
			HC	HCT	
tpZH/ tpZL	turn "ON" time \bar{E} or S_0 to V_{os}	$C_L = 15 \text{ pF}$ $R_L = 1 \text{ k}\Omega$ $V_{CC} = 5 \text{ V}$	28	18	ns
tPHZ/ tPLZ	turn "OFF" time \bar{E} or S_0 to V_{os}		21	13	ns
C_I	input capacitance		3.5	3.5	pF
CPD	power dissipation capacitance per switch	notes 1 and 2	57	57	pF
C_S	max. switch capacitance independent (Y) common (Z)		5 12	5 12	pF pF

$V_{EE} = \text{GND} = 0 \text{ V}$; $T_{amb} = 25^\circ\text{C}$; $t_f = t_r = 6 \text{ ns}$

Notes

1. C_{PD} is used to determine the dynamic power dissipation (P_D in μW):

$$P_D = C_{PD} \times V_{CC}^2 \times f_i + \sum \{(C_L + C_S) \times V_{CC}^2 \times f_o\}$$
 where:

f_i = input frequency in MHz C_L = output load capacitance in pF
 f_o = output frequency in MHz C_S = max. switch capacitance in pF
 $\sum \{(C_L + C_S) \times V_{CC}^2 \times f_o\}$ = sum of outputs V_{CC} = supply voltage in V

2. For HC the condition is $V_I = \text{GND}$ to V_{CC}

For HCT the condition is $V_I = \text{GND}$ to $V_{CC} - 1.5 \text{ V}$

PACKAGE OUTLINES

SEE PACKAGE INFORMATION SECTION

PIN DESCRIPTION

PIN NO.	SYMBOL	NAME AND FUNCTION
1, 5, 2, 4	2Y ₀ to 2Y ₃	independent inputs/outputs
6	\bar{E}	enable input (active LOW)
7	V_{EE}	negative supply voltage
8	GND	ground (0 V)
10, 9	S_0, S_1	select inputs
12, 14, 15, 11	1Y ₀ to 1Y ₃	independent inputs/outputs
13, 3	1Z, 2Z	common inputs/outputs
16	V_{CC}	positive supply voltage

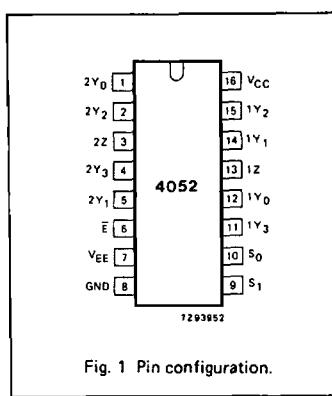


Fig. 1 Pin configuration.

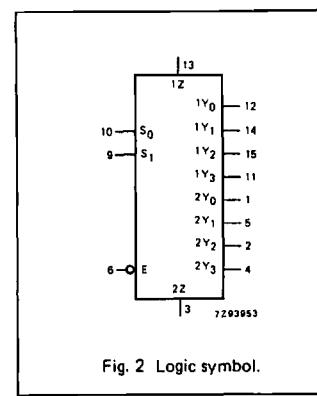


Fig. 2 Logic symbol.

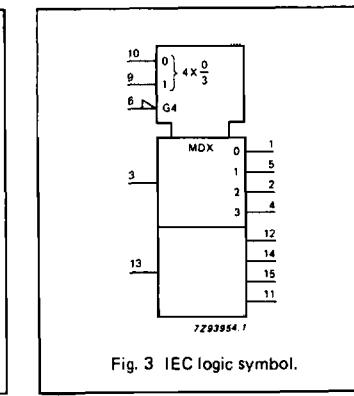


Fig. 3 IEC logic symbol.

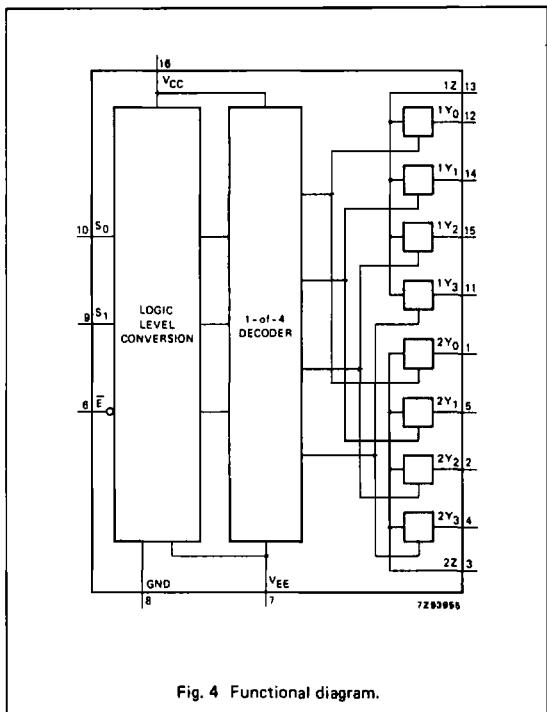


Fig. 4 Functional diagram.

APPLICATIONS

- Analog multiplexing and demultiplexing
- Digital multiplexing and demultiplexing
- Signal gating

FUNCTION TABLE

INPUTS			CHANNEL ON
E	S ₁	S ₀	
L	L	L	nY ₀ - nZ
L	L	H	nY ₁ - nZ
L	H	L	nY ₂ - nZ
L	H	H	nY ₃ - nZ
H	X	X	none

H = HIGH voltage level
L = LOW voltage level
X = don't care

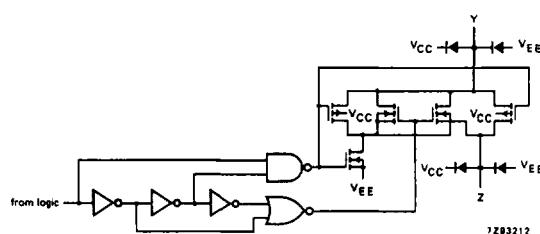


Fig. 5 Schematic diagram (one switch).

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Voltages are referenced to V_{EE} = GND (ground = 0 V)

SYMBOL	PARAMETER	MIN.	MAX.	UNIT	CONDITIONS
V_{CC}	DC supply voltage	-0.5	+11.0	V	
$\pm I_{IK}$	DC digital input diode current		20	mA	for $V_I < -0.5$ V or $V_I > V_{CC} + 0.5$ V
$\pm I_{SK}$	DC switch diode current		20	mA	for $V_S < -0.5$ V or $V_S > V_{CC} + 0.5$ V
$\pm I_S$	DC switch current		25	mA	for -0.5 V < V_S < $V_{CC} + 0.5$ V
$\pm I_{EE}$	DC V_{EE} current		20	mA	
$\pm I_{CC}$ $\pm I_{GND}$	DC V_{CC} or GND current		50	mA	
T_{stg}	storage temperature range	-65	+150	°C	
P_{tot}	power dissipation per package				for temperature range: -40 to +125 °C 74HC/HCT
	plastic DIL		750	mW	above +70 °C: derate linearly with 12 mW/K
	plastic mini-pack (SO)		500	mW	above +70 °C: derate linearly with 8 mW/K
P_S	power dissipation per switch		100	mW	

Note to ratings

To avoid drawing V_{CC} current out of terminals nZ, when switch current flows in terminals nY_n, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminals nZ, no V_{CC} current will flow out of terminals nY_n. In this case there is no limit for the voltage drop across the switch, but the voltages at nY_n and nZ may not exceed V_{CC} or V_{EE} .

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	74HC			74HCT			UNIT	CONDITIONS
		min.	typ.	max.	min.	typ.	max.		
V_{CC}	DC supply voltage V_{CC} -GND	2.0	5.0	10.0	4.5	5.0	5.5	V	see Figs 6 and 7
V_{CC}	DC supply voltage V_{CC} - V_{EE}	2.0	5.0	10.0	2.0	5.0	10.0	V	see Figs 6 and 7
V_I	DC input voltage range	GND		V_{CC}	GND		V_{CC}	V	
V_S	DC switch voltage range	V_{EE}		V_{CC}	V_{EE}		V_{CC}	V	
T_{amb}	operating ambient temperature range	-40		+85	-40		+85	°C	see DC and AC CHARACTERISTICS
T_{amb}	operating ambient temperature range	-40		+125	-40		+125	°C	
t_r, t_f	input rise and fall times		6.0	1000 500 400 250		6.0	500	ns	$V_{CC} = 2.0$ V $V_{CC} = 4.5$ V $V_{CC} = 6.0$ V $V_{CC} = 10.0$ V

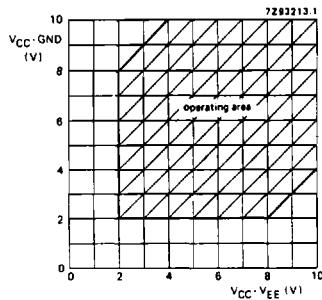


Fig. 6 Guaranteed operating area as a function of the supply voltages for 74HC4052.

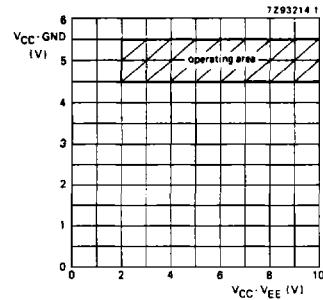


Fig. 7 Guaranteed operating area as a function of the supply voltages for 74HCT4052.

DC CHARACTERISTICS FOR 74HC/HCTFor 74HC: $V_{CC} - GND$ or $V_{CC} - V_{EE} = 2.0, 4.5, 6.0 and 9.0 V$ For 74HCT: $V_{CC} - GND = 4.5$ and 5.5 V; $V_{CC} - V_{EE} = 2.0, 4.5, 6.0 and 9.0 V$

SYMBOL	PARAMETER	T_{amb} ($^{\circ}$ C)							UNIT	TEST CONDITIONS										
		74HC/HCT								V _{CC} V	V _{EE} V	I _S μ A	V _{IS}	V _I						
		+25			-40 to +85		-40 to +125													
		min.	typ.	max.	min.	max.	min.	max.												
R _{ON}	ON resistance (peak)	—	—	180	—	225	—	270	Ω	2.0 4.5 6.0 4.5	0 0 0 -4.5	100 1000 1000 1000	V _{CC} to V _{EE}	V _{IN} or V _{IL}						
R _{ON}	ON resistance (rail)	150	—	—	175	—	210	Ω	2.0 4.5 6.0 4.5	0 0 0 -4.5	100 1000 1000 1000	V _{EE}	V _{IH} or V _{IL}							
R _{ON}	ON resistance (rail)	150	—	—	200	—	240	Ω	2.0 4.5 6.0 4.5	0 0 0 -4.5	100 1000 1000 1000	V _{CC}	V _{IH} or V _{IL}							
ΔR_{ON}	maximum ΔR_{ON} resistance between any two channels	— 9 8 6						Ω	2.0 4.5 6.0 4.5	0 0 0 -4.5		V _{CC} to V _{EE}	V _{IH} or V _{IL}							

Notes to DC characteristics

- At supply voltages ($V_{CC} - V_{EE}$) approaching 2.0 V the analog switch ON-resistance becomes extremely non-linear. There it is recommended that these devices be used to transmit digital signals only, when using these supply voltages.
- For test circuit measuring R_{ON} see Fig. 8.

DC CHARACTERISTICS FOR 74HC

Voltages are referenced to GND (ground = 0 V)

SYMBOL	PARAMETER	T _{amb} (°C)						UNIT	TEST CONDITIONS							
		74HC							V _{CC} V	V _{EE} V	V _I	OTHER				
		+25		-40 to +85		-40 to +125										
		min.	typ.	max.	min.	max.	min.	max.								
V _{IH}	HIGH level input voltage	1.5 3.15 4.2 6.3	1.2 2.4 3.2 4.7		1.5 3.15 4.2 6.3		1.5 3.15 4.2 6.3		V	2.0 4.5 6.0 9.0						
V _{IL}	LOW level input voltage		0.8 2.1 2.8 4.3	0.5 1.35 1.8 2.7		0.5 1.35 1.8 2.7		0.5 1.35 1.8 2.7	V	2.0 4.5 6.0 9.0						
±I _I	input leakage current			0.1 0.2		1.0 2.0		1.0 2.0	μA	6.0 10.0	0	V _{CC} or GND				
±I _S	analog switch OFF-state current per channel			0.1		1.0		1.0	μA	10.0	0	V _{IH} or V _{IL}				
±I _S	analog switch OFF-state current all channels			0.2		2.0		2.0	μA	10.0	0	V _{IH} or V _{IL}				
±I _S	analog switch ON-state current			0.2		2.0		2.0	μA	10.0	0	V _{IH} or V _{IL}				
I _{CC}	quiescent supply current			8.0 16.0		80.0 160.0		160.0 320.0	μA	6.0 10.0	0	V _{CC} or GND				
												V _{IS} = V _{EE} or V _{CC} ; V _{DS} = V _{CC} or V _{EE}				

AC CHARACTERISTICS FOR 74HC

GND = 0 V; t_r = t_f = 6 ns; C_L = 50 pF

SYMBOL	PARAMETER	T _{amb} (°C)						UNIT	TEST CONDITIONS							
		74HC							V _{CC} V	V _{EE} V	OTHER					
		+25		-40 to +85		-40 to +125										
		min.	typ.	max.	min.	max.	min.	max.								
t _{PHL} / t _{PLH}	propagation delay V _{IS} to V _{OS}		14 5 4 4	60 12 10 8		75 15 13 10		90 18 15 12	ns	2.0 4.5 6.0 4.5	0 0 0 -4.5	R _L = ∞; C _L = 50 pF (see Fig. 18)				
t _{PZH} / t _{PZL}	turn "ON" time E to V _{OS} S _H to V _{OS}		105 38 30 26	325 65 55 46		405 81 69 58		490 98 83 69	ns	2.0 4.5 6.0 4.5	0 0 0 -4.5	R _L = ∞; C _L = 50 pF (see Figs 19, 20 and 21)				
t _{PHZ} / t _{PLZ}	turn "OFF" time E to V _{OS} S _H to V _{OS}		74 27 22 22	250 50 43 38		315 63 54 48		375 75 64 57	ns	2.0 4.5 6.0 4.5	0 0 0 -4.5	R _L = 1 kΩ; C _L = 50 pF (see Figs 19, 20 and 21)				

DC CHARACTERISTICS FOR 74HCT

Voltages are referenced to GND (ground = 0)

SYMBOL	PARAMETER	T _{amb} (°C)								UNIT	TEST CONDITIONS				
		74HCT									V _{CC}	V _{EE}	V _I	OTHER	
		+25			−40 to +85		−40 to +125				V	V	V		
		min.	typ.	max.	min.	max.	min.	max.	min.						
V _{IH}	HIGH level input voltage	2.0	1.6		2.0		2.0		2.0	V	4.5 to 5.5				
V _{IL}	LOW level input voltage		1.2	0.8		0.8		0.8	0.8	V	4.5 to 5.5				
±I _I	input leakage current			0.1		1.0		1.0	1.0	μA	5.5	0	V _{CC} or GND		
±I _S	analog switch OFF-state current per channel			0.1		1.0		1.0	1.0	μA	10.0	0	V _{IH} or V _{IL}	V _{S1} = V _{CC} − V _{EE} (see Fig. 10)	
±I _S	analog switch OFF-state current all channels			0.2		2.0		2.0	2.0	μA	10.0	0	V _{IH} or V _{IL}	V _{S1} = V _{CC} − V _{EE} (see Fig. 11)	
±I _S	analog switch ON-state current			0.2		2.0		2.0	2.0	μA	10.0	0	V _{IH} or V _{IL}	V _{S1} = V _{CC} − V _{EE} (see Fig. 11)	
I _{CC}	quiescent supply current			8.0 16.0		80.0 160.0		160.0 320.0	160.0 320.0	μA	5.5 5.0	0 −5.0	V _{CC} or GND	V _{is} = V _{EE} or V _{CC} ; V _{os} = V _{CC} or V _{EE}	
ΔI _{CC}	additional quiescent supply current per input pin for unit load coefficient is 1 (note 1)		100	360		450		490	490	μA	4.5 to 5.5	0	V _{CC} − 2.1V	other inputs at V _{CC} or GND	

Note to HCT types

1. The value of additional quiescent supply current (ΔI_{CC}) for a unit load of 1 is given here.To determine ΔI_{CC} per input, multiply this value by the unit load coefficient shown in the table below.

INPUT	UNIT LOAD COEFFICIENT
S _n E	0.45 0.45

AC CHARACTERISTICS FOR 74HCT

GND = 0 V; $t_r = t_f = 6$ ns; $C_L = 50$ pF

SYMBOL	PARAMETER	T _{amb} (°C)						UNIT	TEST CONDITIONS					
		74HCT							V _{CC} V	V _{EE} V	OTHER			
		+25			−40 to +85		−40 to +125							
		min.	typ.	max.	min.	max.	min.	max.						
t _{PHL} / t _{PLH}	propagation delay V_I to V_{O5}	5 4	12 8		15 10		18 12		ns	4.5 4.5	0 −4.5	$R_L = \infty$; $C_L = 50$ pF (see Fig. 18)		
t _{PZH} / t _{PZL}	turn "ON" time \bar{E} to V_{O5} S_n to V_{O5}	41 28	70 48		88 60		105 72		ns	4.5 4.5	0 −4.5	$R_L = 1$ kΩ; $C_L = 50$ pF (see Figs 19, 20 and 21)		
t _{PHZ} / t _{PLZ}	turn "OFF" time \bar{E} to V_{O5} S_n to V_{O5}	26 21	50 38		63 48		75 57		ns	4.5 4.5	0 −4.5	$R_L = 1$ kΩ; $C_L = 50$ pF (see Figs 19, 20 and 21)		

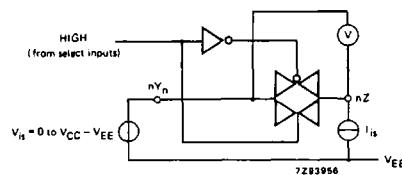
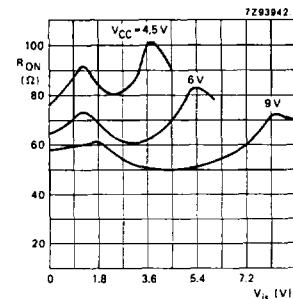
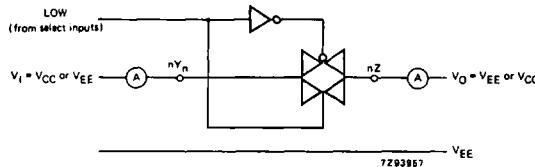
Fig. 8 Test circuit for measuring R_{ON}.Fig. 9 Typical R_{ON} as a function of input voltage V_{IS} for $V_{IS} = 0$ to $V_{CC} - V_{EE}$.

Fig. 10 Test circuit for measuring OFF-state current.

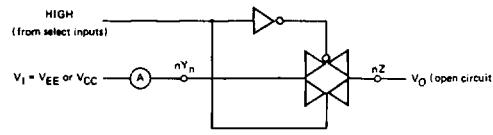


Fig. 11 Test circuit for measuring ON-state current.

ADDITIONAL AC CHARACTERISTICS FOR 74HC/HCT

Recommended conditions and typical values

GND = 0 V; $T_{amb} = 25^\circ C$

SYMBOL	PARAMETER	typ.	UNIT	V_{CC} V	V_{EE} V	$V_{IS(p-p)}$ V	CONDITIONS
	sine-wave distortion $f = 1 \text{ kHz}$	0.04 0.02	% %	2.25 4.5	-2.25 -4.5	4.0 8.0	$R_L = 10 \text{ k}\Omega$; $C_L = 50 \text{ pF}$ (see Fig. 14)
	sine-wave distortion $f = 10 \text{ kHz}$	0.12 0.06	% %	2.25 4.5	-2.25 -4.5	4.0 8.0	$R_L = 10 \text{ k}\Omega$; $C_L = 50 \text{ pF}$ (see Fig. 14)
	switch "OFF" signal feed-through	-50 -50	dB dB	2.25 4.5	-2.25 -4.5	note 1	$R_L = 600 \Omega$; $C_L = 50 \text{ pF}$; $f = 1 \text{ MHz}$ (see Figs 12 and 15)
	crosstalk between any two switches/ multiplexers	-60 -60	dB dB	2.25 4.5	-2.25 -4.5	note 1	$R_L = 600 \Omega$; $C_L = 50 \text{ pF}$; $f = 1 \text{ MHz}$ (see Fig. 16)
$V_{(p-p)}$	crosstalk voltage between control and any switch (peak-to-peak value)	110 220	mV mV	4.5 4.5	0 -4.5		$R_L = 600 \Omega$; $C_L = 50 \text{ pF}$; $f = 1 \text{ MHz}$ (E or S_n , square-wave between V_{CC} and GND, $t_r = t_f = 6 \text{ ns}$) (see Fig. 17)
f_{max}	minimum frequency response (-3dB)	170 180	MHz MHz	2.25 4.5	-2.25 -4.5	note 2	$R_L = 50 \Omega$; $C_L = 50 \text{ pF}$ (see Figs 13 and 14)
C_S	maximum switch capacitance independent (Y) common (Z)	5 12	pF pF				

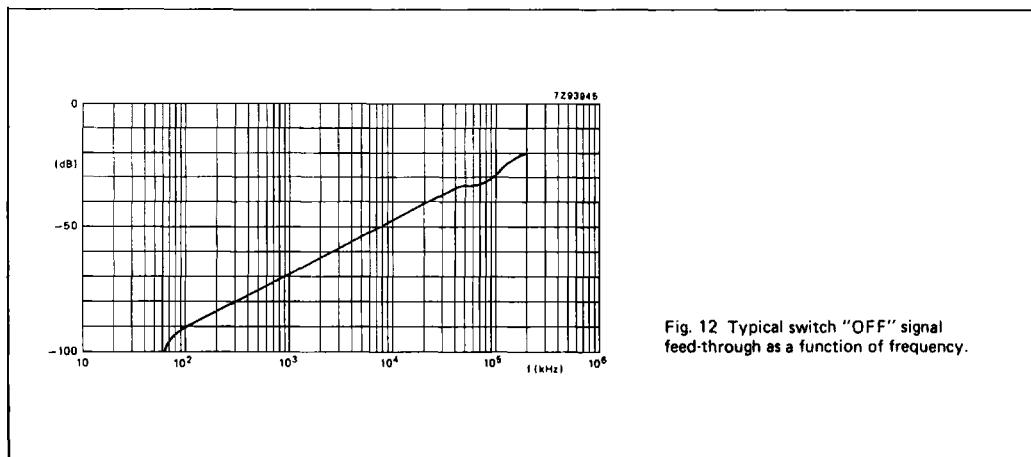
Notes to AC characteristics

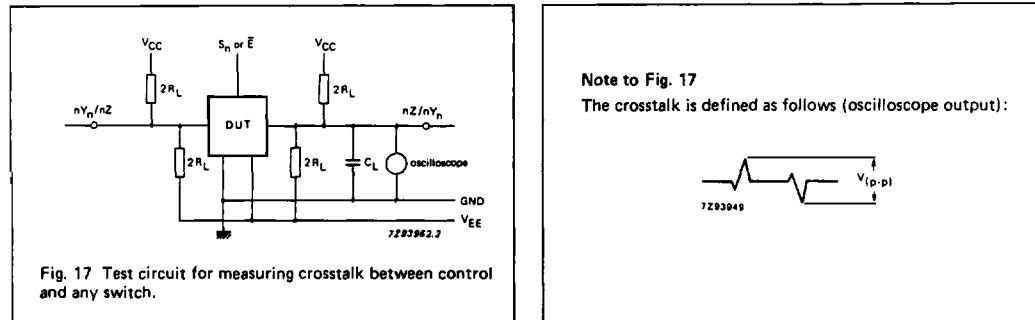
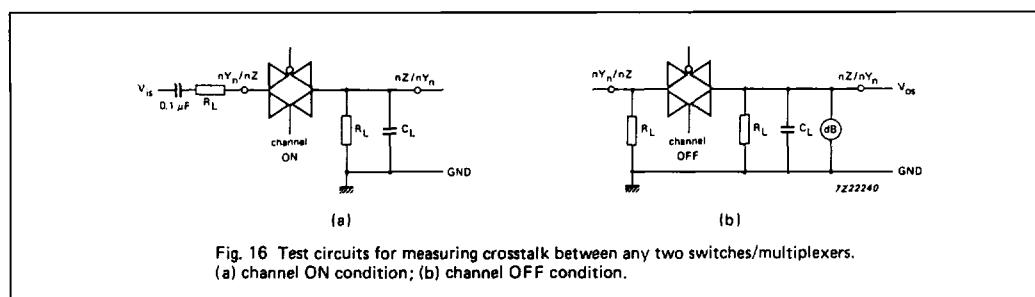
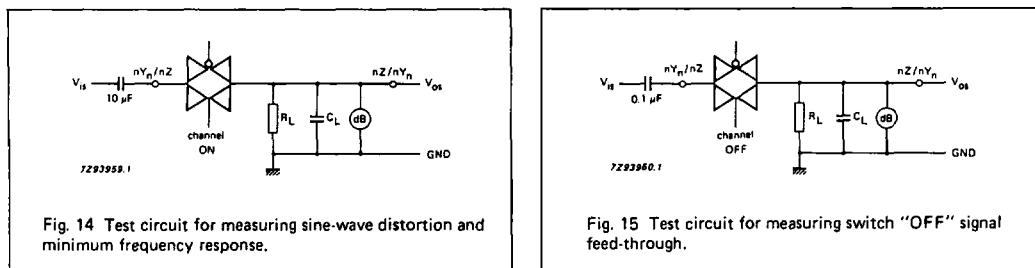
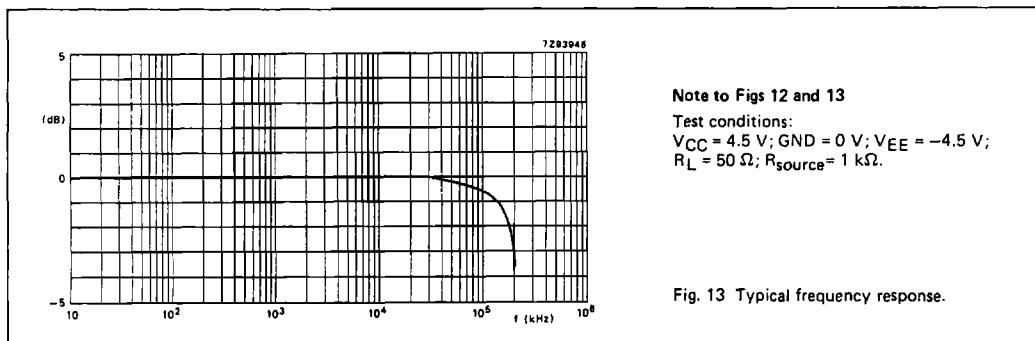
General note

 V_{IS} is the input voltage at an nY_n or nZ terminal, whichever is assigned as an input. V_{OS} is the output voltage at an nY_n or nZ terminal, whichever is assigned as an output.

Notes

1. Adjust input voltage V_{IS} to 0 dBm level (0 dBm = 1 mW into 600Ω).
2. Adjust input voltage V_{IS} to 0 dBm level at V_{OS} for 1 MHz (0 dBm = 1 mW into 50Ω).





AC WAVEFORMS

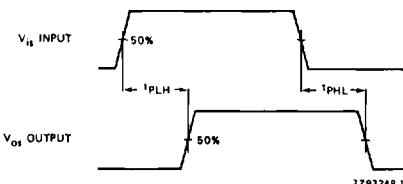


Fig. 18 Waveforms showing the input (V_{IS}) to output (V_{OS}) propagation delays.

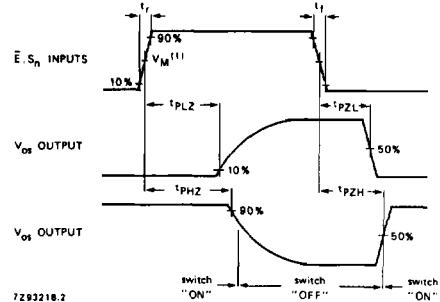


Fig. 19 Waveforms showing the turn-ON and turn-OFF times.

Note to Fig. 19

- (1) HC : $V_M = 50\%$; $V_I = \text{GND to } V_{CC}$.
HCT: $V_M = 1.3 \text{ V}$; $V_I = \text{GND to } 3 \text{ V}$.

TEST CIRCUIT AND WAVEFORMS

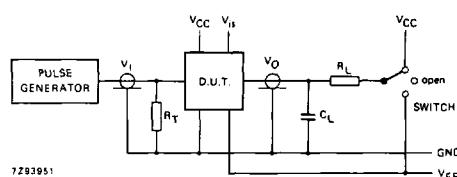


Fig. 20 Test circuit for measuring AC performance.

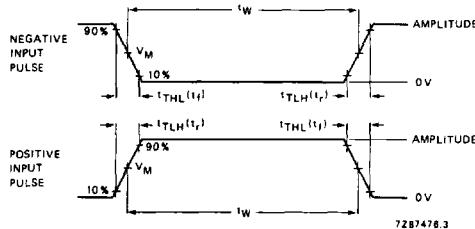


Fig. 21 Input pulse definitions.

Conditions

TEST	SWITCH	V_{IS}
t _{PZH}	V_{EE}	V_{CC}
t _{PZL}	V_{CC}	V_{EE}
t _{PHZ}	V_{EE}	V_{CC}
t _{PLZ}	V_{CC}	V_{EE}
others	open	pulse

FAMILY	AMPLITUDE	V_M	$t_r; t_f$	
			$f_{max}/$ PULSE WIDTH	OTHER
74HC	V_{CC}	50%	< 2 ns	6 ns
74HCT	3.0 V	1.3 V	< 2 ns	6 ns

Definitions for Figs 20 and 21:

C_L = load capacitance including jig and probe capacitance
(see AC CHARACTERISTICS for values).

R_T = termination resistance should be equal to the output impedance Z_O of the pulse generator.

$t_r = t_f = 6$ ns; when measuring f_{max} , there is no constraint to t_r, t_f with 50% duty factor.